Docket No.: 055071-0328

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

byre Application of

Customer Number: 20277

Robert John SOCHA, et al.

Confirmation Number: 2388

Application No.: 10/756,829

Group Art Unit: 1756

Filed: January 14, 2004

Examiner: Yet to be assigned

For: METHOD OF OPTICAL PROXIMITY CORRECTION DESIGN FOR CONTACT HOLE

MASK

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Mail Stop IDS Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

10/756,829

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

McDERMOTO WILL & EMERY LLP

Michael E. Fogarty Registration No. 36,139

Please recognize our Customer No. 20277 as our correspondence address.

600 13th Street, N.W. Washington, DC 20005-3096 Phone: 202.756.8000 MEF:jam

Facsimile: 202.756.8087 **Date: May 24, 2005**

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